

PMWD15UN

Dual N-channel μ TrenchMOS™ ultra low level FET

Rev. 04 — 5 April 2005

Product data sheet

1. Product profile

1.1 General description

Dual common drain N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS™ technology.

1.2 Features

- Surface mounting package
- Very low threshold voltage
- Low profile
- Fast switching

1.3 Applications

- Portable appliances
- Battery management
- PCMCIA cards
- Load switching

1.4 Quick reference data

- $V_{DS} \leq 20$ V
- $P_{tot} \leq 4.2$ W
- $I_D \leq 11.6$ A
- $R_{DSon} \leq 18.5$ m Ω

2. Pinning information

Table 1: Pinning

Pin	Description	Simplified outline	Symbol
1, 8	drain (D)	<p>SOT530-1 (TSSOP8)</p>	<p>mb1600</p>
2, 3	source1 (S1)		
4	gate1 (G1)		
5	gate2 (G2)		
6, 7	source2 (S2)		

3. Ordering information

Table 2: Ordering information

Type number	Package		
	Name	Description	Version
PMWD15UN	TSSOP8	plastic thin shrink small outline package; 8 leads; body width 4.4 mm	SOT530-1

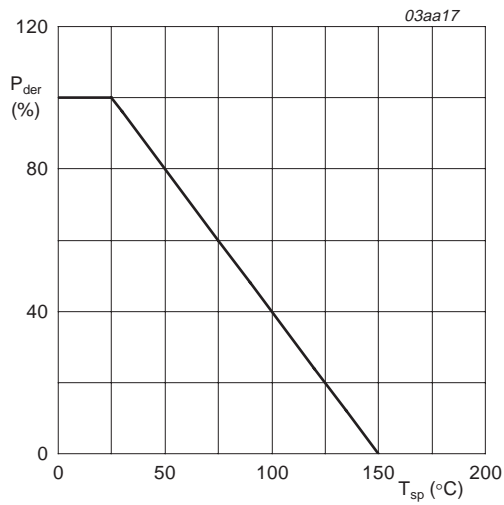
4. Limiting values

Table 3: Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

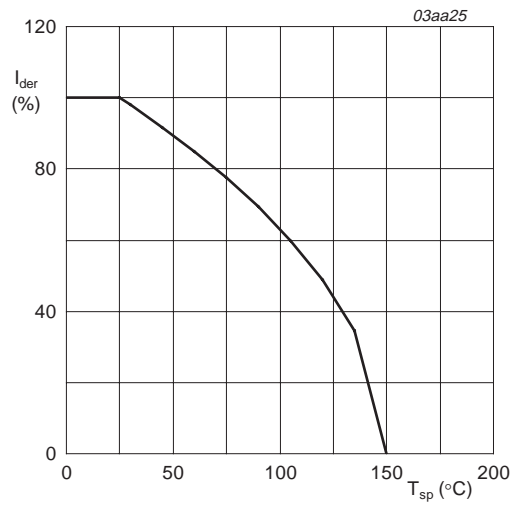
Symbol	Parameter	Conditions	Min	Max	Unit	
V_{DS}	drain-source voltage (DC)	$25\text{ °C} \leq T_j \leq 150\text{ °C}$	-	20	V	
V_{DGR}	drain-gate voltage (DC)	$25\text{ °C} \leq T_j \leq 150\text{ °C}$; $R_{GS} = 20\text{ k}\Omega$	-	20	V	
V_{GS}	gate-source voltage		-	± 12	V	
I_D	drain current (DC)	$T_{sp} = 25\text{ °C}$; $V_{GS} = 4.5\text{ V}$; Figure 2 and 3	[1]	-	11.6	A
		$T_{sp} = 100\text{ °C}$; $V_{GS} = 4.5\text{ V}$; Figure 2	[1]	-	7.3	A
I_{DM}	peak drain current	$T_{sp} = 25\text{ °C}$; pulsed; $t_p \leq 10\text{ }\mu\text{s}$; Figure 3	[1]	-	46.4	A
P_{tot}	total power dissipation	$T_{sp} = 25\text{ °C}$; Figure 1	[1]	-	4.2	W
T_{stg}	storage temperature		-55	+150	$^{\circ}\text{C}$	
T_j	junction temperature		-55	+150	$^{\circ}\text{C}$	
Source-drain diode						
I_S	source (diode forward) current (DC)	$T_{sp} = 25\text{ °C}$	[1]	-	3.5	A
I_{SM}	peak source (diode forward) current	$T_{sp} = 25\text{ °C}$; pulsed; $t_p \leq 10\text{ }\mu\text{s}$	[1]	-	14	A

[1] Single device conducting.



$$P_{der} = \frac{P_{tot}}{P_{tot(25^\circ\text{C})}} \times 100\%$$

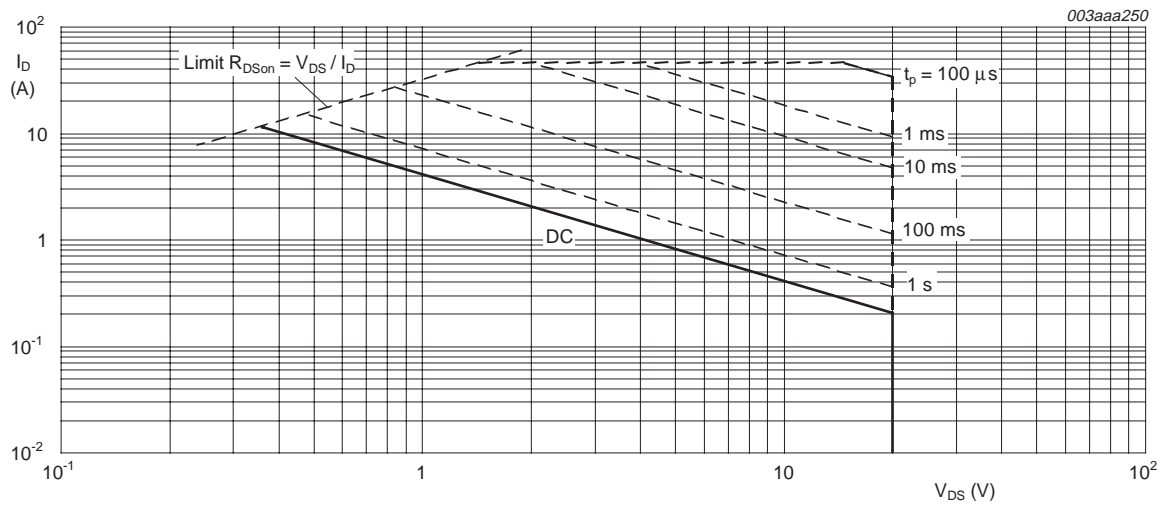
Fig 1. Normalized total power dissipation as a function of solder point temperature



$V_{GS} \geq 4.5\text{ V}$

$$I_{der} = \frac{I_D}{I_{D(25^\circ\text{C})}} \times 100\%$$

Fig 2. Normalized continuous drain current as a function of solder point temperature



$T_{sp} = 25^\circ\text{C}$; I_{DM} is single pulse

Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

5. Thermal characteristics

Table 4: Thermal characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$R_{th(j-sp)}$	thermal resistance from junction to solder point	Figure 4	-	-	30	K/W
$R_{th(j-a)}$	thermal resistance from junction to ambient	mounted on a printed-circuit board; minimum footprint; vertical in still air	-	100	-	K/W

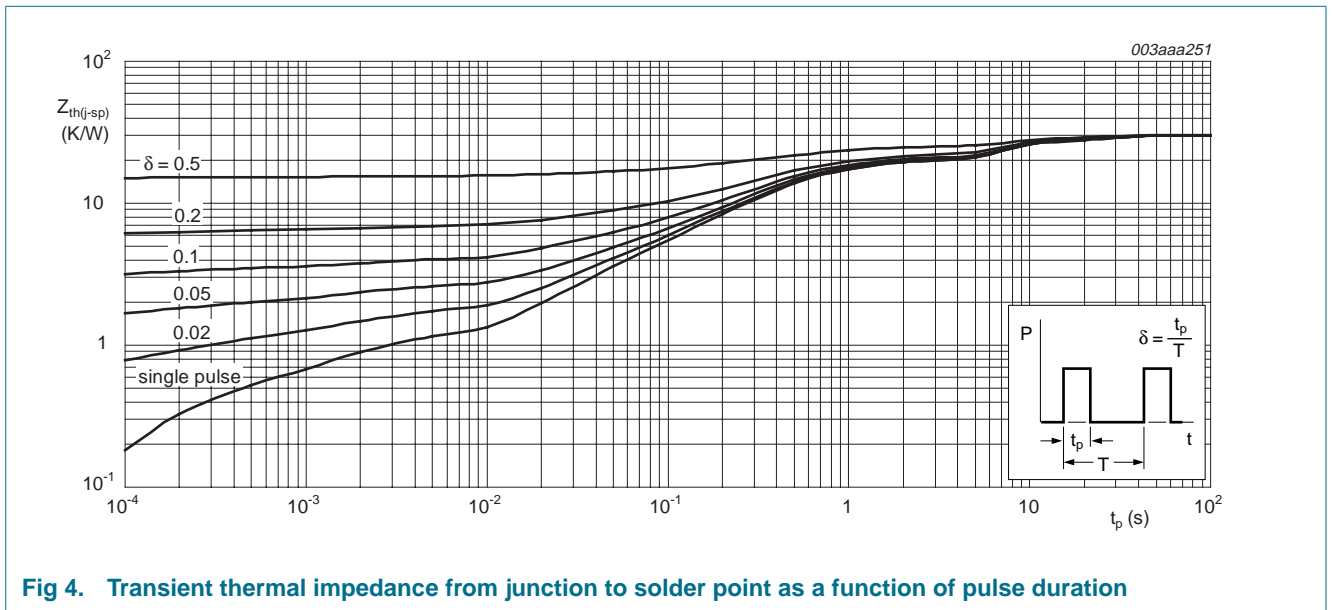
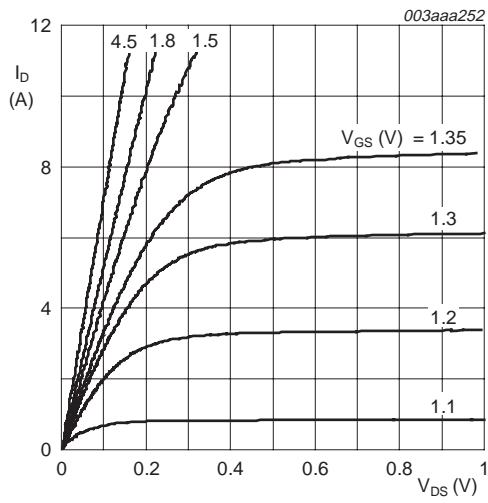


Fig 4. Transient thermal impedance from junction to solder point as a function of pulse duration

6. Characteristics

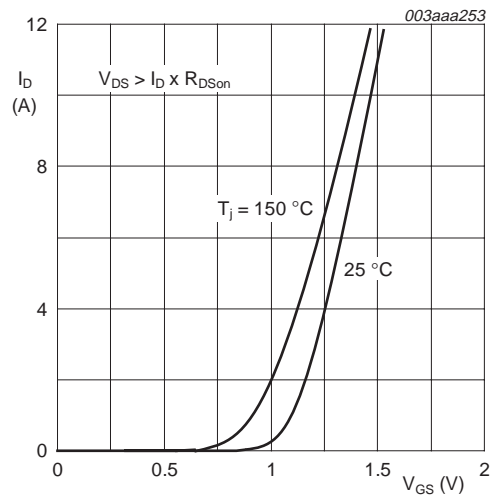
Table 5: Characteristics
 $T_j = 25\text{ }^\circ\text{C}$ unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Static characteristics						
$V_{(BR)DSS}$	drain-source breakdown voltage	$I_D = 250\ \mu\text{A}$; $V_{GS} = 0\ \text{V}$ $T_j = 25\text{ }^\circ\text{C}$	20	-	-	V
		$T_j = -55\text{ }^\circ\text{C}$	18	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 1\ \text{mA}$; $V_{DS} = V_{GS}$; Figure 9 and 10	0.45	0.7	-	V
I_{DSS}	drain-source leakage current	$V_{DS} = 20\ \text{V}$; $V_{GS} = 0\ \text{V}$ $T_j = 25\text{ }^\circ\text{C}$	-	-	1	μA
		$T_j = 150\text{ }^\circ\text{C}$	-	-	100	μA
I_{GSS}	gate-source leakage current	$V_{GS} = \pm 10\ \text{V}$; $V_{DS} = 0\ \text{V}$	-	-	100	nA
$R_{DS(on)}$	drain-source on-state resistance	$V_{GS} = 4.5\ \text{V}$; $I_D = 5\ \text{A}$; Figure 7 and 8 $T_j = 25\text{ }^\circ\text{C}$	-	15.3	18.5	m Ω
		$T_j = 150\text{ }^\circ\text{C}$	-	26	31	m Ω
		$V_{GS} = 1.8\ \text{V}$; $I_D = 4.5\ \text{A}$; Figure 7 and 8	-	20	28.5	m Ω
		$V_{GS} = 2.5\ \text{V}$; $I_D = 5\ \text{A}$; Figure 7 and 8	-	17	20.5	m Ω
Dynamic characteristics						
$Q_{g(tot)}$	total gate charge	$I_D = 4\ \text{A}$; $V_{DS} = 16\ \text{V}$; $V_{GS} = 4.5\ \text{V}$; Figure 13	-	22.2	-	nC
Q_{gs}	gate-source charge		-	2.1	-	nC
Q_{gd}	gate-drain (Miller) charge		-	6.2	-	nC
C_{iss}	input capacitance	$V_{GS} = 0\ \text{V}$; $V_{DS} = 16\ \text{V}$; $f = 1\ \text{MHz}$; Figure 11	-	1450	-	pF
C_{oss}	output capacitance		-	280	-	pF
C_{rss}	reverse transfer capacitance		-	190	-	pF
$t_{d(on)}$	turn-on delay time	$V_{DS} = 10\ \text{V}$; $R_L = 10\ \Omega$; $V_{GS} = 4.5\ \text{V}$; $R_G = 6\ \Omega$	-	14.7	-	ns
t_r	rise time		-	22.4	-	ns
$t_{d(off)}$	turn-off delay time		-	57	-	ns
t_f	fall time		-	33	-	ns
Source-drain diode						
V_{SD}	source-drain (diode forward) voltage	$I_S = 5\ \text{A}$; $V_{GS} = 0\ \text{V}$; Figure 12	-	0.67	1.2	V
t_{rr}	reverse recovery time	$I_S = 5\ \text{A}$; $dI_S/dt = -100\ \text{A}/\mu\text{s}$; $V_{GS} = 0\ \text{V}$; $V_R = 20\ \text{V}$	-	45	-	ns
Q_r	recovered charge		-	12.3	-	nC



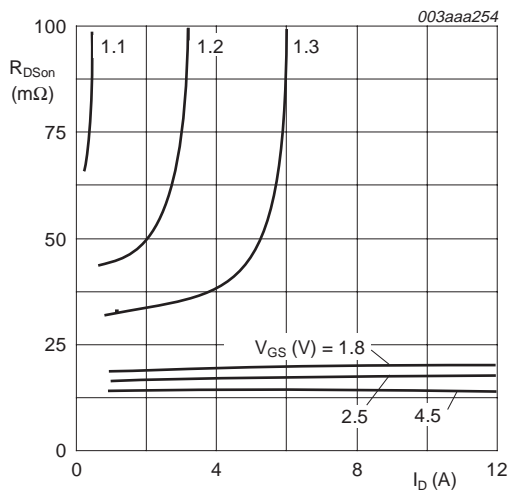
$T_j = 25^\circ\text{C}$

Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values



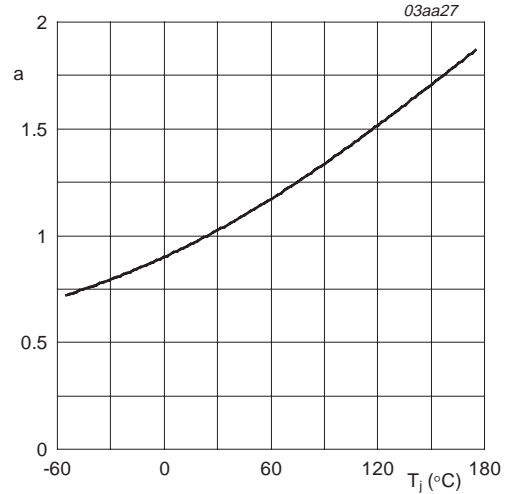
$T_j = 25^\circ\text{C}$ and 150°C ; $V_{DS} > I_D \times R_{DSon}$

Fig 6. Transfer characteristics: drain current as a function of gate-source voltage; typical values



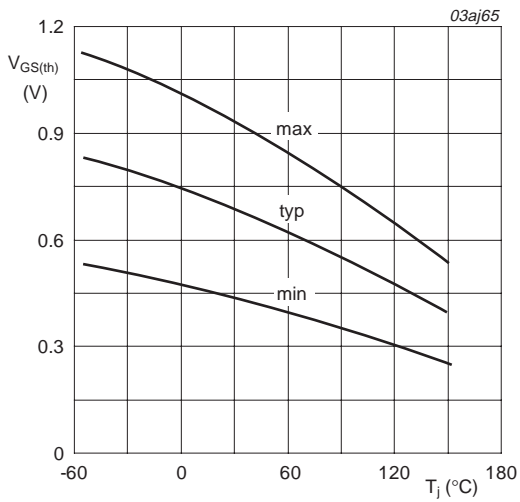
$T_j = 25^\circ\text{C}$

Fig 7. Drain-source on-state resistance as a function of drain current; typical values



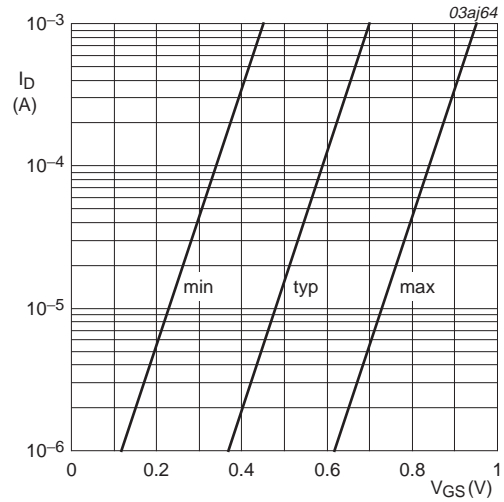
$$a = \frac{R_{DSon}}{R_{DSon(25^\circ\text{C})}}$$

Fig 8. Normalized drain-source on-state resistance factor as a function of junction temperature



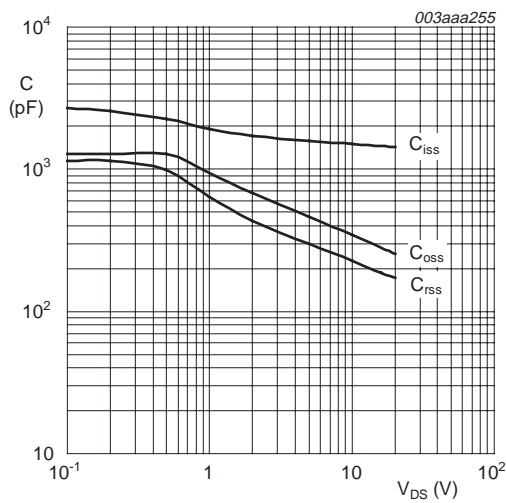
$I_D = 1 \text{ mA}; V_{DS} = V_{GS}$

Fig 9. Gate-source threshold voltage as a function of junction temperature



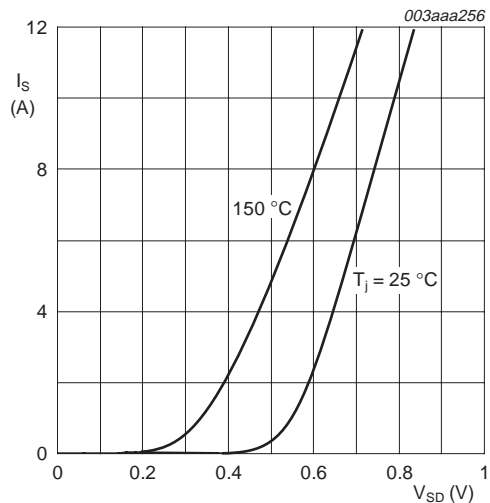
$T_j = 25 \text{ }^{\circ}C; V_{DS} = 5 \text{ V}$

Fig 10. Sub-threshold drain current as a function of gate-source voltage



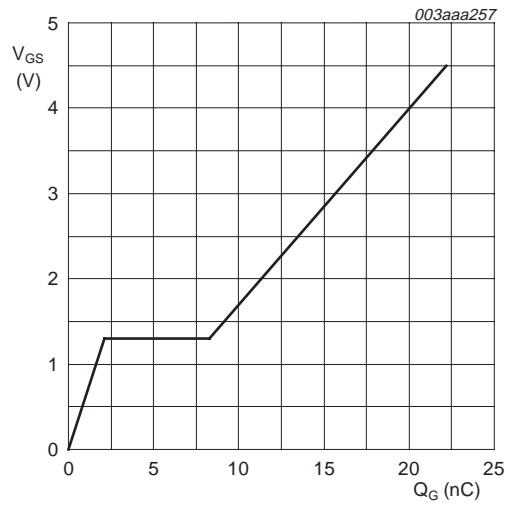
$V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$

Fig 11. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values



$T_j = 25 \text{ }^{\circ}C \text{ and } 150 \text{ }^{\circ}C; V_{GS} = 0 \text{ V}$

Fig 12. Source (diode forward) current as a function of source-drain (diode forward) voltage; typical values



I_D = 4 A; V_{DD} = 16 V

Fig 13. Gate-source voltage as a function of gate charge; typical values

7. Package outline

TSSOP8: plastic thin shrink small outline package; 8 leads; body width 4.4 mm

SOT530-1

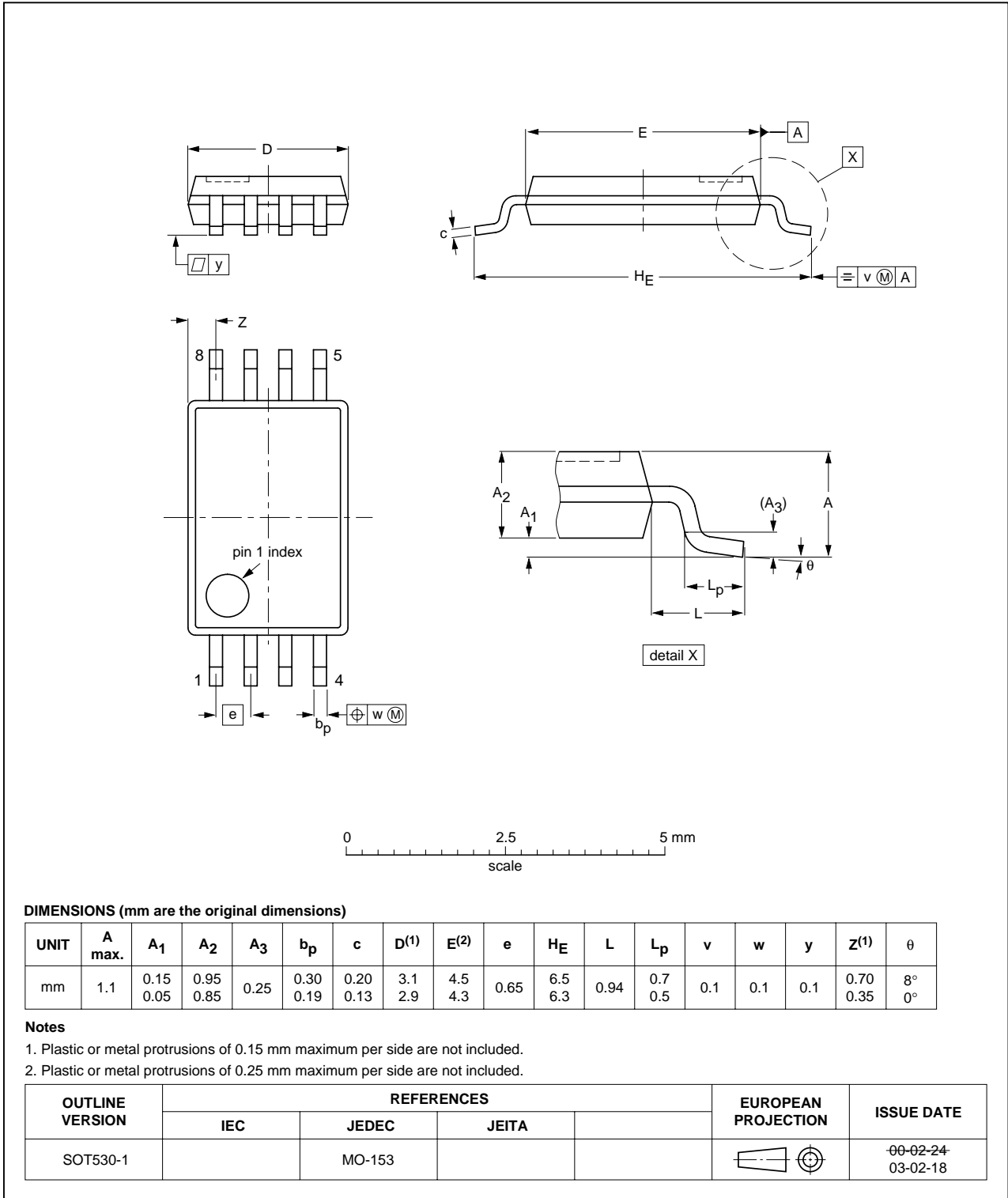


Fig 14. Package outline SOT530-1 (TSSOP8)

8. Revision history

Table 6: Revision history

Document ID	Release date	Data sheet status	Change notice	Doc. number	Supersedes
PMWD15UN_4	20050405	Product data sheet	-	9397 750 14713	PMWD15UN-03
Modifications:	<ul style="list-style-type: none"> • The format of this data sheet has been redesigned to comply with the new presentation and information standard of Philips Semiconductors. • I_D and P_{tot} data revised in Section 1.4 “Quick reference data”. • I_D, I_{DM}, P_{tot}, I_S and I_{SM} data revised in Table 3 “Limiting values”. • Figure 3 revised in Section 4 “Limiting values”. • $R_{th(j-sp)}$ data revised in Table 4 “Thermal characteristics”. • Figure 4 revised in Section 5 “Thermal characteristics”. 				
PMWD15UN-03	20040220	Product data	-	9397 750 12677	PMWD15UN-02
PMWD15UN-02	20030807	Product data	-	9397 750 11777	PMWD15UN-01
PMWD15UN-01	20030204	Product data	-	9397 750 10829	-

9. Data sheet status

Level	Data sheet status ^[1]	Product status ^{[2] [3]}	Definition
I	Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
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10. Definitions

Short-form specification — The data in a short-form specification is extracted from a full data sheet with the same type number and title. For detailed information see the relevant data sheet or data handbook.

Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 60134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

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14. Contents

1	Product profile	1
1.1	General description	1
1.2	Features	1
1.3	Applications	1
1.4	Quick reference data	1
2	Pinning information	1
3	Ordering information	2
4	Limiting values	2
5	Thermal characteristics	4
6	Characteristics	5
7	Package outline	9
8	Revision history	10
9	Data sheet status	11
10	Definitions	11
11	Disclaimers	11
12	Trademarks	11
13	Contact information	11



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